

January 1995 Revised November 1999

## 74ABT126

# **Quad Buffer with 3-STATE Outputs**

### **General Description**

The ABT126 contains four independent non-inverting buffers with 3-STATE outputs.

#### **Features**

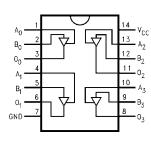
- Non-inverting buffers
- Output sink capability of 64 mA, source capability of 32 m
- Guaranteed latchup protection
- High impedance glitch free bus loading during entire power up and power down cycle
- Nondestructive hot insertion capability
- Disable time less than enable time to avoid bus contention

## **Ordering Code:**

Order Number	Package Number	Package Description
74ABT126CSC	M14A	14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-120, 0.150" Narrow Body
74ABT126CSJ	M14D	14-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
74ABT126CMTC	MTC14	14-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide

Devices also available in Tape and Reel. Specify by appending suffix letter "X" to the ordering code

# **Connection Diagram**



### **Pin Descriptions**

Pin Names	Descriptions			
A <sub>n</sub> , B <sub>n</sub>	Inputs			
O <sub>n</sub>	Outputs			

#### **Function Table**

Inp	Output	
A <sub>n</sub>	B <sub>n</sub>	O <sub>n</sub>
Н	L	L
Н	Н	Н
L	Х	Z

H = HIGH Voltage Level

L = LOW Voltage Level Z = HIGH Impedance X = Immaterial

### **Absolute Maximum Ratings**(Note 1)

# +150°C Co

 $\begin{array}{ll} \mbox{Storage Temperature} & -65\mbox{°C to } +150\mbox{°C} \\ \mbox{Ambient Temperature under Bias} & -55\mbox{°C to } +125\mbox{°C} \\ \end{array}$ 

Ambient Temperature under Bias  $-55^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$ Junction Temperature under Bias  $-55^{\circ}\text{C}$  to  $+150^{\circ}\text{C}$ V<sub>CC</sub> Pin Potential to Ground Pin -0.5V to +7.0V

Voltage Applied to Any Output

in the Disabled or

Power-Off State -0.5 V to 5.5 V in the HIGH State  $-0.5 \text{V to } \text{V}_{\text{CC}}$ 

Current Applied to Output

in LOW State (Max) twice the rated  $I_{OL}$  (mA)

DC Latchup Source Current

(Across Comm Operating Range) -300 mA

Over Voltage Latchup (I/O) 10V

# Recommended Operating Conditions

Free Air Ambient Temperature -40°C to +85°C Supply Voltage +4.5V to +5.5V

Minimum Input Edge Rate (ΔV/Δt)

Data Input 50 mV/ns
Enable Input 100 mV/ns

Note 1: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation

under these conditions is not implied.

-300 mA Note 2: Either voltage limit or current limit is sufficient to protect inputs.

#### **DC Electrical Characteristics**

Symbol	Parameter	Min	Тур	Max	Units	v <sub>cc</sub>	Conditions
V <sub>IH</sub>	V <sub>IH</sub> Input HIGH Voltage				V		Recognized HIGH Signal
V <sub>IL</sub>	Input LOW Voltage			8.0	V		Recognized LOW Signal
V <sub>CD</sub>	Input Clamp Diode Voltage			-1.2	V	Min	I <sub>IN</sub> = -18 mA
V <sub>OH</sub>	Output HIGH Voltage	2.5			V	Min	$I_{OH} = -3 \text{ mA}$
		2.0			V	Min	$I_{OH} = -32 \text{ mA}$
V <sub>OL</sub>	Output LOW Voltage			0.55	V	Min	I <sub>OL</sub> = 64 mA
I <sub>IH</sub>	Input HIGH Current			1	^	Max	V <sub>IN</sub> = 2.7V (Note 3)
				1	μΑ	IVIAX	$V_{IN} = V_{CC}$
I <sub>BVI</sub>	Input HIGH Current Breakdown Test			7	μΑ	Max	V <sub>IN</sub> = 7.0V
I <sub>IL</sub>	Input LOW Current			-1	μА	Max	V <sub>IN</sub> = 0.5V (Note 3)
				-1	μА	Iviax	$V_{IN} = 0.0V$
V <sub>ID</sub>	Input Leakage Test	4.75			V	0.0	$I_{ID} = 1.9 \mu A$ , All Other Pin Grounded
I <sub>OZH</sub>	Output Leakage Current			10	μΑ	0 – 5.5V	$V_{OUT} = 2.7V; \overline{OE}_n = 2.0V$
I <sub>OZL</sub>	Output Leakage Current			-10	μΑ	0 – 5.5V	$V_{OUT} = 0.5V; \overline{OE}_n = 2.0V$
los	Output Short-Circuit Current	-100		-275	mA	Max	V <sub>OUT</sub> = 0.0V
I <sub>CEX</sub>	Output HIGH Leakage Current			50	μΑ	Max	$V_{OUT} = V_{CC}$
I <sub>ZZ</sub>	Bus Drainage Test			100	μΑ	0.0	V <sub>OUT</sub> = 5.5V; All Others GND
Іссн	Power Supply Current			50	μΑ	Max	All Outputs HIGH
I <sub>CCL</sub>	Power Supply Current			15	mA	Max	All Outputs LOW
I <sub>CCZ</sub>	Power Supply Current			50	μΑ	Max	$\overline{OE}_n = V_{CC};$
							All Others at V <sub>CC</sub> or Ground
I <sub>CCT</sub>	Additional I <sub>CC</sub> /Input Outputs Enabled			1.5	mA		V <sub>I</sub> = V <sub>CC</sub> - 2.1V
	Outputs 3-STATE			1.5	mA		Enable Input $V_I = V_{CC} - 2.1V$
	Outputs 3-STATE			50	μΑ	Max	Data Input V <sub>I</sub> = V <sub>CC</sub> - 2.1V
							All Others at V <sub>CC</sub> or Ground
I <sub>CCD</sub>	Dynamic I <sub>CC</sub> No Load				mA/		Outputs Open
	(Note 3)			0.1	MHz	Max	$\overline{OE}_n = GND$ , (Note 4)
							One Bit Toggling, 50% Duty Cycle

Note 3: Guaranteed, but not tested.

Note 4: For 8 bits toggling,  $I_{CCD} < 0.8 \text{ mA/MHz}.$ 

# **AC Electrical Characteristics**

Symbol	Parameter		$T_A = +25$ °C $V_{CC} = +5V$ $C_L = 50 \text{ pF}$		$T_A = -40^{\circ}$ $V_{CC} = 4$ $C_L =$	Units	
		Min	Тур	Max	Min	Max	
t <sub>PLH</sub>	Propagation Delay	1.0		4.4	1.0	4.4	ns
t <sub>PHL</sub>	Data to Outputs	1.0		4.6	1.0	4.6	
t <sub>PZH</sub>	Output Enable	1.0		6.5	1.0	6.5	20
$t_{PZL}$	Time	1.0		6.5	1.0	6.5	ns
t <sub>PHZ</sub>	Output Disable	1.0		5.8	1.0	5.8	ns
t <sub>PLZ</sub>	Time	1.0		5.5	1.0	5.5	

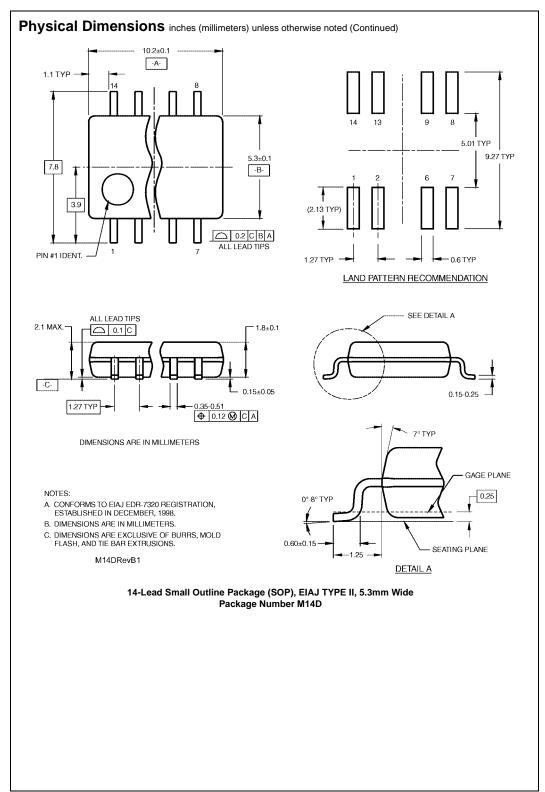
# Capacitance

Symbol	Parameter	Тур	Units	Conditions T <sub>A</sub> = 25°C
C <sub>IN</sub>	Input Capacitance	5.0	pF	V <sub>CC</sub> = 0V
C <sub>OUT</sub> (Note 5)	Output Capacitance	9.0	pF	V <sub>CC</sub> = 5.0V

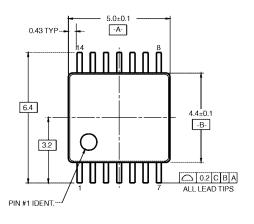
Note 5:  $C_{OUT}$  is measured at frequency f = 1 MHz, per MIL-STD-883, Method 3012.

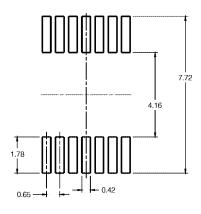
# Physical Dimensions inches (millimeters) unless otherwise noted $\frac{0.335 - 0.344}{(8.509 - 8.738)}$ LEAD NO. 1 IDENT $\frac{0.150 - 0.157}{(3.810 - 3.988)}$ $\frac{0.010-0.020}{(0.254-0.508)}$ $\frac{0.053 - 0.069}{(1.346 - 1.753)}$ 8° MAX TYP ALL LEADS $\frac{0.004 - 0.010}{(0.102 - 0.254)}$ SEATING PLANE 0.014 (0.356) 0.008 - 0.010 (0.203 - 0.254) TYP ALL LEADS $\frac{0.014 - 0.020}{(0.356 - 0.508)} \text{ TYP}$ 0.050 (1.270) TYP 0.016 - 0.050 (0.406 - 1.270) TYP ALL LEADS 0.004 (0.102) ALL LEAD TIPS 0.008 (0.203) TYP

14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-120, 0.150" Narrow Body Package Number M14A

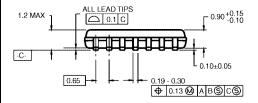


### Physical Dimensions inches (millimeters) unless otherwise noted (Continued)





LAND PATTERN RECOMMENDATION

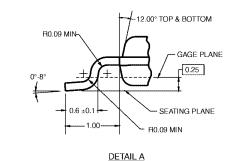




#### NOTES:

- A. CONFORMS TO JEDEC REGISTRATION MO-153, VARIATION AB, REF NOTE 6, DATE 7/93.
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.
- D. DIMENSIONS AND TOLERANCES PER ANSI Y14.5M, 1982.

MTC14RevC3



14-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide Package Number MTC14

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